Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/777,164	LEE ET AL.	
Examiner	Art Unit	
RICARDO L. OSORIO	2629	

SEARCHED									
Class	Subclass	Date	Examiner						
345	87 90-92 94-96	7/23/07	RLO						
V	103	\downarrow							

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
		V 76 3 781	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	_	DATE	EXMF	
EAST	Search	7/23/07	RL	
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